

**Notice of References Cited**

Application/Control No.

10/550,235

Applicant(s)/Patent Under  
Reexamination  
CHIU ET AL.

Examiner

RONALD HUPCZEY, JR

Art Unit

3739

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,026,959	06-1991	Ito et al.	219/690
*	B	US-4,800,899	01-1989	Elliott, Martin K.	607/156
*	C	US-5,057,106	10-1991	Kasevich et al.	606/33
*	D	US-6,033,401	03-2000	Edwards et al.	606/41
*	E	US-6,802,840	10-2004	Chin et al.	606/41
*	F	US-5,776,176	07-1998	Rudie, Eric N.	607/101
*	G	US-5,405,346	04-1995	Grundy et al.	606/41
*	H	US-3,230,957	01-1966	GERHARD SEIFERT	607/156
*	I	US-5,364,392	11-1994	Warner et al.	606/34
*	J	US-5,246,438	09-1993	Langberg, Edwin	606/33
*	K	US-4,841,988	06-1989	Fetter et al.	607/154
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.